

DATA SHEET

74ABT543A

Octal latched transceiver
with dual enable (3-State)

Product specification

1995 Apr 19

IC23 Data Handbook

Philips Semiconductors



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PHILIPS

Octal latched transceiver with dual enable (3-State)

74ABT543A

FEATURES

- Combines 74ABT245 and 74ABT373 type functions in one device
- 8-bit octal transceiver with D-type latch
- Back-to-back registers for storage
- Separate controls for data flow in each direction
- Output capability: +64mA/-32mA
- Live insertion/extraction permitted
- Power-up 3-State
- Power-up reset
- Latch-up protection exceeds 500mA per Jedec JC40.2 Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

DESCRIPTION

The 74ABT543A high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT543A Octal Registered Transceiver contains two sets of D-type latches for temporary storage of data flowing in either direction. Separate Latch Enable ($\overline{LEAB}$, $\overline{LEBA}$) and Output Enable ($\overline{OEAB}$, $\overline{OEBA}$) inputs are provided for each register to permit independent control of data transfer in either direction. The outputs are guaranteed to sink 64mA.

FUNCTIONAL DESCRIPTION

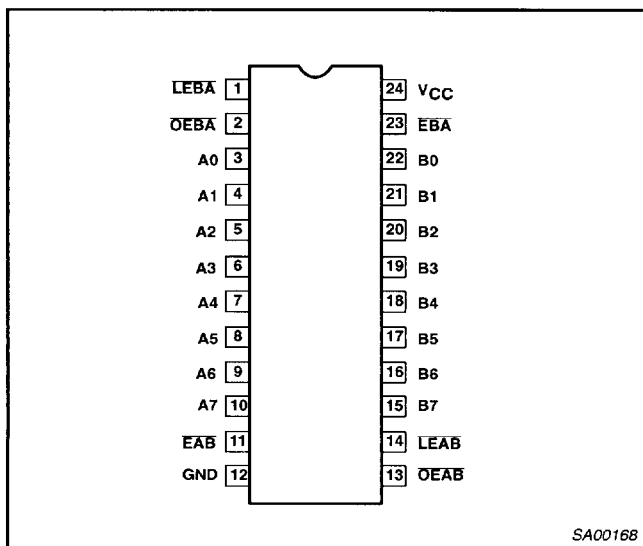
The 74ABT543A contains two sets of eight D-type latches, with separate control pins for each set. Using data flow from A to B as an example, when the A-to-B Enable ($\overline{EAB}$) input and the A-to-B Latch Enable ($\overline{LEAB}$) input are Low the A-to-B path is transparent. A subsequent Low-to-High transition of the $\overline{LEAB}$ signal puts the A data into the latches where it is stored and the B outputs no longer change with the A inputs. With $\overline{EAB}$ and $\overline{OEAB}$ both Low, the 3-State B output buffers are active and display the data present at the outputs of the A latches.

Control of data flow from B to A is similar, but using the $\overline{EBA}$, $\overline{LEBA}$, and $\overline{OEBA}$ inputs.

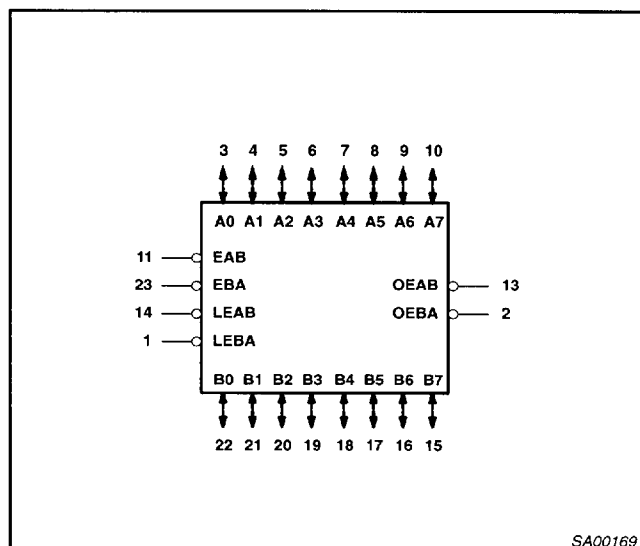
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE	DRAWING NUMBER
24-pin plastic DIP	-40°C to +85°C	74ABT543AN	SOT222-1
24-pin plastic SOL	-40°C to +85°C	74ABT543AD	SOT137-1
24-pin plastic SSOP type II	-40°C to +85°C	74ABT543ADB	SOT340-1
24-pin plastic TSSOP type III	-40°C to +85°C	74ABT543APW	SOT355-1

PIN CONFIGURATION



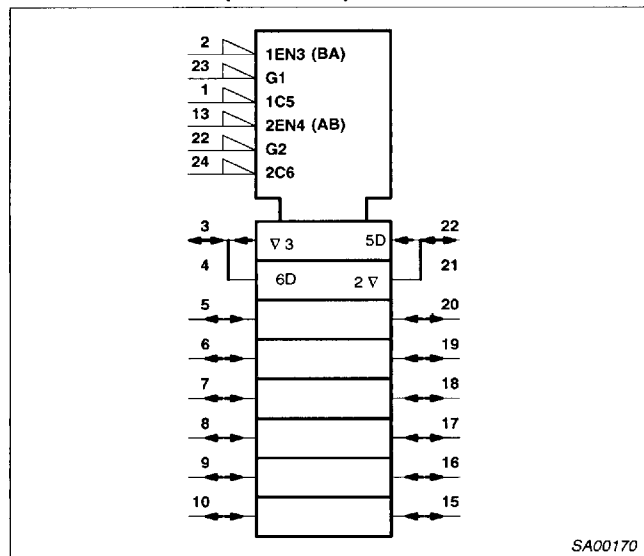
LOGIC SYMBOL



Octal latched transceiver with dual enable (3-State)

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LOGIC SYMBOL (IEEE/IEC)



PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
14, 1	$\overline{LEAB} / \overline{LEBA}$	A to B / B to A Latch Enable input (active-Low)
11, 23	$\overline{EAB} / \overline{EBA}$	A to B / B to A Enable input (active-Low)
13, 2	$\overline{OEAB} / \overline{OEBA}$	A to B / B to A Output Enable input (active-Low)
3, 4, 5, 6, 7, 8, 9, 10	A0 – A7	Port A, 3-State outputs
22, 21, 20, 19, 18, 17, 16, 15	B0 – B7	Port B, 3-State outputs
12	GND	Ground (0V)
24	V _{CC}	Positive supply voltage

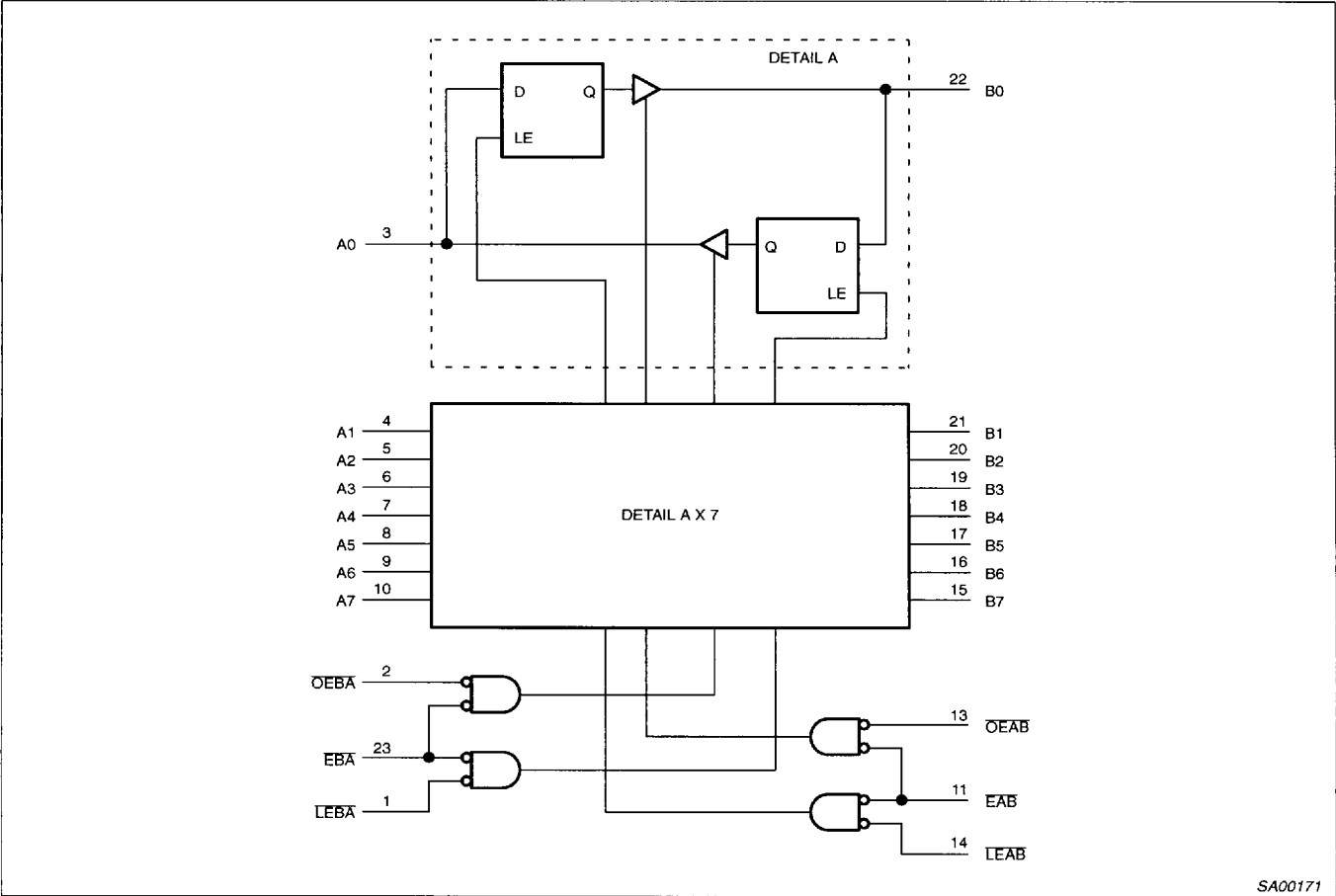
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS T _{amb} = 25°C; GND = 0V	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	C _L = 50pF; V _{CC} = 5V	2.9 3.6	ns
C _{IN}	Input capacitance	V _I = 0V or V _{CC}	4	pF
C _{I/O}	I/O capacitance	Outputs disabled; V _O = 0V or V _{CC}	7	pF
I _{CCZ}	Total supply current	Outputs disabled; V _{CC} = 5.5V	110	μA

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LOGIC DIAGRAM



FUNCTION TABLE

INPUTS				OUTPUTS	STATUS
OE _{XX}	EX _{XX}	LE _{XX}	A _n or B _n	B _n or A _n	
H	X	X	X	Z	Disabled
X	H	X	X	Z	Disabled
L	↑	L	h	Z	Disabled + Latch
L	↑	L	l	Z	
L	L	↑	h	H	Latch + Display
L	L	↑	l	L	
L	L	L	H	H	Transparent
L	L	L	L	L	
L	L	H	X	NC	Hold

H = High voltage level
h = High voltage level one set-up time prior to the Low-to-High transition of LE_{XX} or EX_{XX} (XX = AB or BA)
L = Low voltage level
l = Low voltage level one set-up time prior to the Low-to-High transition of LE_{XX} or EX_{XX} (XX = AB or BA)
X = Don't care
↑ = Low-to-High transition of LE_{XX} or EX_{XX} (XX = AB or BA)
NC= No change
Z = High impedance or "off" state

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ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V_{CC}	DC supply voltage		-0.5 to +7.0	V
I_{IK}	DC input diode current	$V_I < 0$	-18	mA
V_I	DC input voltage ³		-1.2 to +7.0	V
I_{OK}	DC output diode current	$V_O < 0$	-50	mA
V_{OUT}	DC output voltage ³	output in Off or High state	-0.5 to +5.5	V
I_{OUT}	DC output current	output in Low state	128	mA
T_{stg}	Storage temperature range		-65 to 150	°C

NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS		UNIT
		Min	Max	
V_{CC}	DC supply voltage	4.5	5.5	V
V_I	Input voltage	0	V_{CC}	V
V_{IH}	High-level input voltage	2.0		V
V_{IL}	Low-level input voltage		0.8	V
I_{OH}	High-level output current		-32	mA
I_{OL}	Low-level output current		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
T_{amb}	Operating free-air temperature range	-40	+85	°C

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DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER		TEST CONDITIONS	LIMITS					UNIT
				T _{amb} = +25°C			T _{amb} = -40°C to +85°C		
				Min	Typ	Max	Min	Max	
V _{IK}	Input clamp voltage		V _{CC} = 4.5V; I _{IK} = -18mA		-0.9	-1.2		-1.2	V
V _{OH}	High-level output voltage		V _{CC} = 4.5V; I _{OH} = -3mA; V _I = V _{IL} or V _{IH}	2.5	3.2		2.5		V
			V _{CC} = 5.0V; I _{OH} = -3mA; V _I = V _{IL} or V _{IH}	3.0	3.7		3.0		V
			V _{CC} = 4.5V; I _{OH} = -32mA; V _I = V _{IL} or V _{IH}	2.0	2.3		2.0		V
V _{OL}	Low-level output voltage		V _{CC} = 4.5V; I _{OL} = 64mA; V _I = V _{IL} or V _{IH}		0.3	0.55		0.55	V
V _{RST}	Power-up output low voltage ³		V _{CC} = 5.5V; I _O = 1mA; V _I = GND or V _{CC}		0.13	.55		.55	V
I _I	Input leakage current	Control pins	V _{CC} = 5.5V; V _I = GND or 5.5V		±0.01	±1.0		±1.0	μA
		Data pins	V _{CC} = 5.5V; V _I = GND or 5.5V		±5	±100		±100	μA
I _{OFF}	Power-off leakage current		V _{CC} = 0.0V; V _O or V _I ≤ 4.5V		±5.0	±100		±100	μA
I _{PU/PD}	Power-up/down 3-State output current ⁴		V _{CC} = 2.1V; V _O = 0.5V; V _I = GND or V _{CC} ; V _{OE} = Don't care		±5.0	±50		±50	μA
I _{IH} + I _{OZH}	3-State output High current		V _{CC} = 5.5V; V _O = 2.7V; V _I = V _{IL} or V _{IH}		5.0	50		50	μA
I _{IL} + I _{OZL}	3-State output Low current		V _{CC} = 5.5V; V _O = 0.5V; V _I = V _{IL} or V _{IH}		-5.0	-50		-50	μA
I _{CEX}	Output high leakage current		V _{CC} = 5.5V; V _O = 5.5V; V _I = GND or V _{CC}		5.0	50		50	μA
I _O	Output current ¹		V _{CC} = 5.5V; V _O = 2.5V	-40	-65	-180	-40	-180	mA
I _{CCH}	Quiescent supply current		V _{CC} = 5.5V; Outputs High, V _I = GND or V _{CC}		110	250		250	μA
I _{CCL}				20	30		30	mA	
I _{CCZ}				110	250		250	μA	
ΔI _{CC}	Additional supply current per input pin ²		V _{CC} = 5.5V; one input at 3.4V, other inputs at V _{CC} or GND; V _{CC} = 5.5V		0.3	1.5		1.5	mA

NOTES:

- Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
- This is the increase in supply current for each input at 3.4V.
- For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.
- This parameter is valid for any V_{CC} between 0V and 2.1V, with a transition time of up to 10msec. From $V_{CC} = 2.1\text{V}$ to $V_{CC} = 5\text{V} \pm 10\%$, a transition time of up to 100 μsec is permitted.

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AC CHARACTERISTICS

GND = 0V, $t_R = t_F = 2.5\text{ns}$, $C_L = 50\text{pF}$, $R_L = 500\Omega$

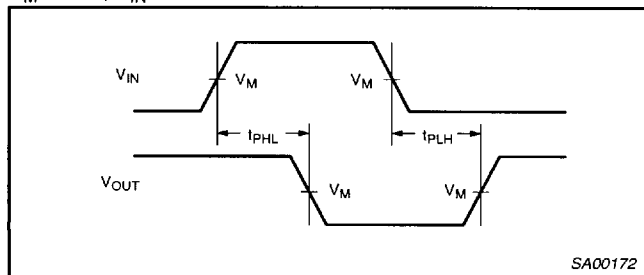
SYMBOL	PARAMETER	WAVEFORM	LIMITS					UNIT
			$T_{\text{amb}} = +25^{\circ}\text{C}$ $V_{\text{CC}} = +5.0\text{V}$			$T_{\text{amb}} = -40$ to $+85^{\circ}\text{C}$ $V_{\text{CC}} = +5.0\text{V} \pm 0.5\text{V}$		
			Min	Typ	Max	Min	Max	
t_{PLH} t_{PHL}	Propagation delay An to Bn, Bn to An	2	1.0 1.9	2.9 3.6	4.5 5.2	1.0 1.9	5.2 5.7	ns
t_{PLH} t_{PHL}	Propagation delay LEBA to An, LEAB to Bn	1 2	1.0 2.1	3.4 4.3	5.1 6.0	1.0 2.1	6.2 6.7	ns
t_{PZH} t_{PZL}	Output enable time OEBA to An, OEAB to Bn	4 5	1.0 2.0	3.2 4.3	5.1 5.9	1.0 2.0	6.2 6.6	ns
t_{PHZ} t_{PLZ}	Output disable time OEBA to An, OEAB to Bn	4 5	2.0 1.0	4.0 3.0	5.7 4.6	2.0 1.0	6.2 5.0	ns
t_{PZH} t_{PZL}	Output enable time EBA to An, EAB to Bn	4 5	1.0 2.0	3.4 4.4	5.1 6.1	1.0 2.0	6.2 6.8	ns
t_{PHZ} t_{PLZ}	Output disable time EBA to An, EAB to Bn	4 5	2.0 1.0	3.6 3.0	5.4 4.6	2.0 1.0	5.9 5.0	ns

AC SETUP REQUIREMENTS

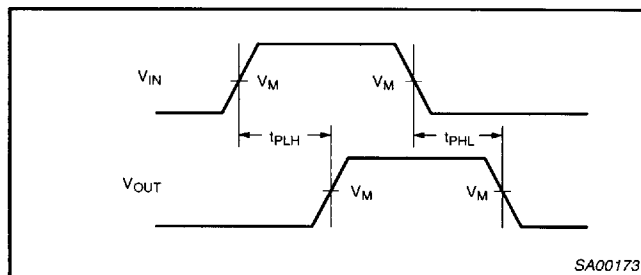
GND = 0V, $t_R = t_F = 2.5\text{ns}$, $C_L = 50\text{pF}$, $R_L = 500\Omega$

SYMBOL	PARAMETER	WAVEFORM	LIMITS			UNIT
			$T_{\text{amb}} = +25^\circ\text{C}$ $V_{\text{CC}} = +5.0\text{V}$		$T_{\text{amb}} = -40$ to $+85^\circ\text{C}$ $V_{\text{CC}} = +5.0\text{V} \pm 0.5\text{V}$	
			Min	Typ	Min	
$t_{\text{s}}(\text{H})$ $t_{\text{s}}(\text{L})$	Setup time An to $\overline{\text{LEAB}}$, Bn to $\overline{\text{LEBA}}$	3	2.5 3.0	1.0 1.4	2.5 3.0	ns
$t_{\text{h}}(\text{H})$ $t_{\text{h}}(\text{L})$	Hold time An to $\overline{\text{LEAB}}$, Bn to $\overline{\text{LEBA}}$	3	0.5 0.5	-0.8 -0.6	0.5 0.5	ns
$t_{\text{s}}(\text{H})$ $t_{\text{s}}(\text{L})$	Setup time An to $\overline{\text{EAB}}$, Bn to $\overline{\text{EBA}}$	3	3.5 3.0	1.3 1.4	3.5 3.0	ns
$t_{\text{h}}(\text{H})$ $t_{\text{h}}(\text{L})$	Hold time An to $\overline{\text{EAB}}$, Bn to $\overline{\text{EBA}}$	3	0.5 0.5	-0.8 -0.6	0.5 0.5	ns
$t_{\text{w}}(\text{L})$	Latch enable pulse width, Low	3	3.5	1.0	3.5	ns

AC WAVEFORMS

 $V_M = 1.5\text{V}$, $V_{\text{IN}} = \text{GND to } 3.0\text{V}$ 

Waveform 1. Propagation Delay For Inverting Output



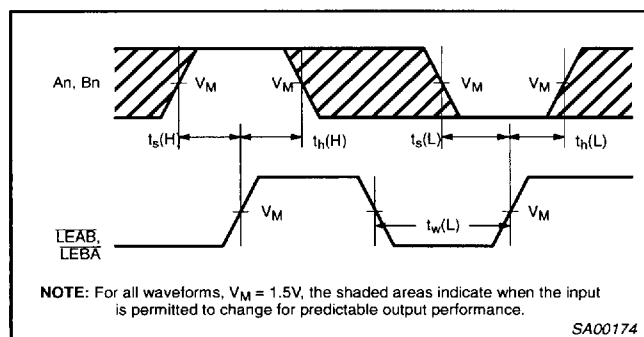
Waveform 2. Propagation Delay For Non-Inverting Output

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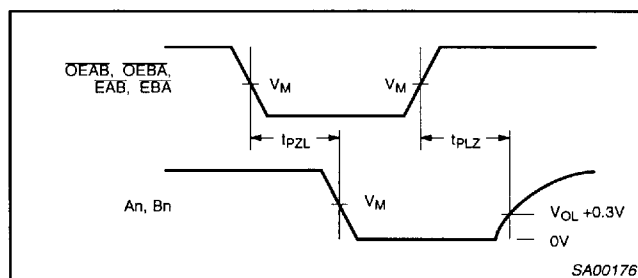
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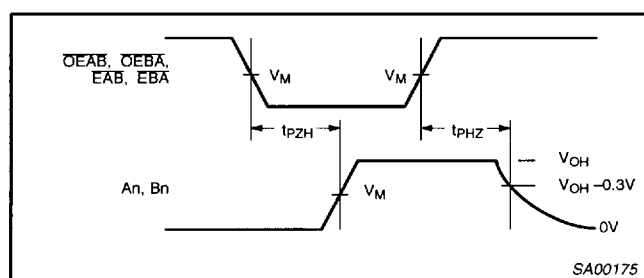
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Waveform 3. Data Setup and Hold Times And Latch Enable Pulse Width

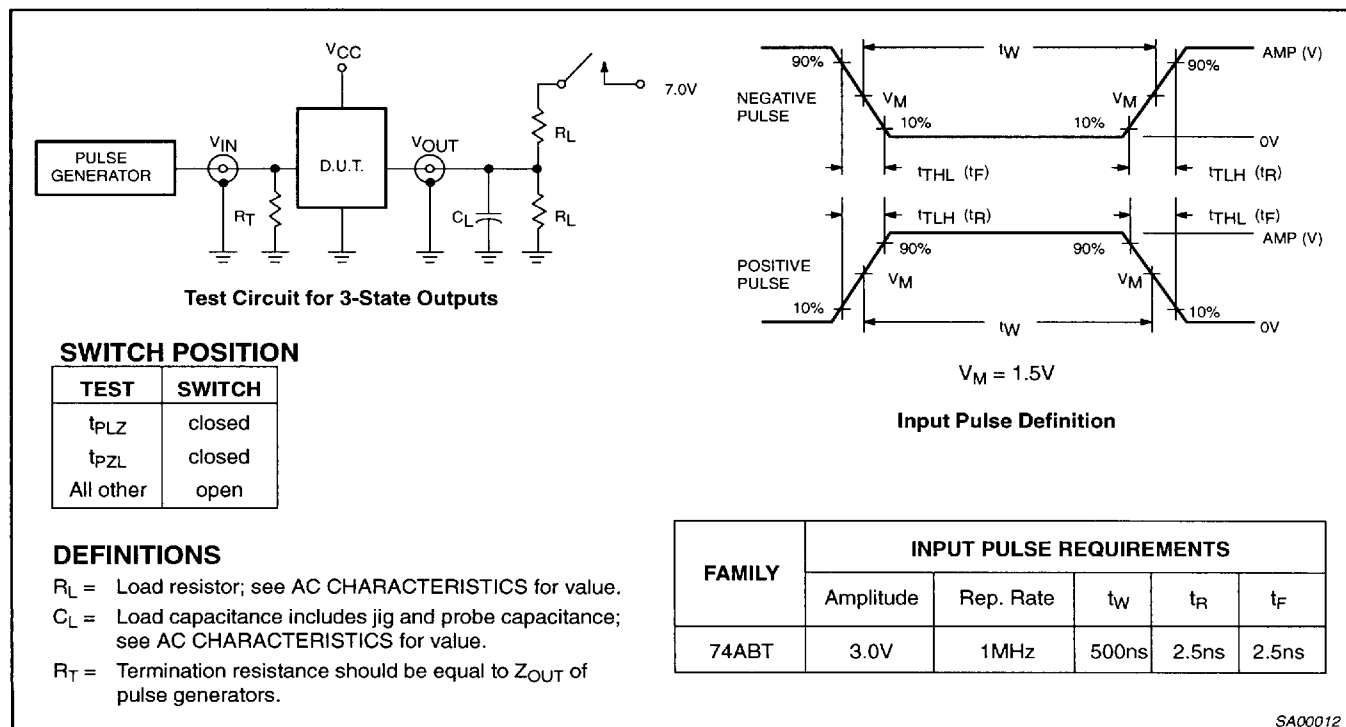


Waveform 5. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level



Waveform 4. 3-State Output Enable Time to High Level and Output Disable Time from High Level

TEST CIRCUIT AND WAVEFORM

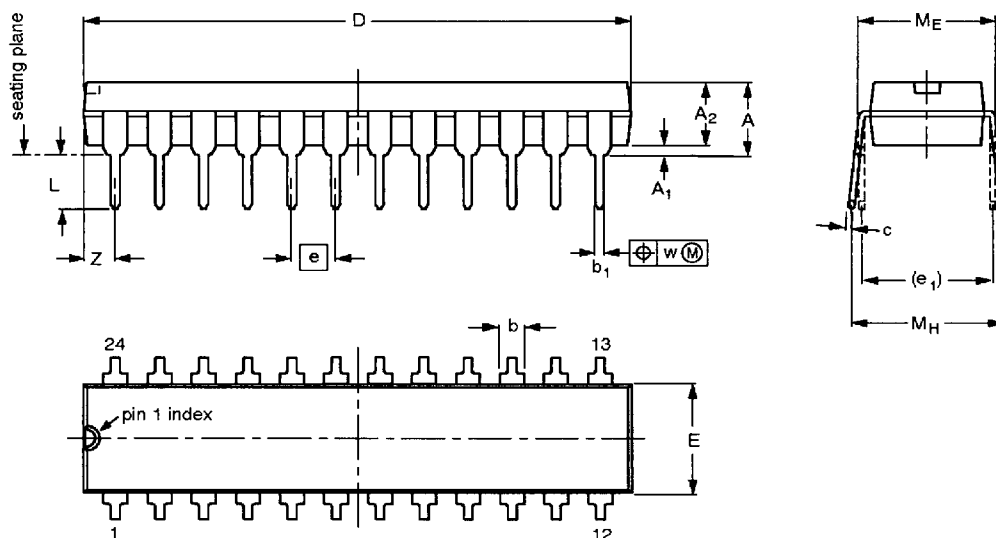


Octal latched transceiver with dual enable (3-State)

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DIP24: plastic dual in-line package; 24 leads (300 mil)

SOT222-1



0 5 10 mm
scale

DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	M _E	M _H	w	Z ⁽¹⁾ max.
mm	4.70	0.38	3.94	1.63 1.14	0.56 0.43	0.36 0.25	31.9 31.5	6.73 6.48	2.54	7.62	3.51 3.05	8.13 7.62	10.03 7.62	0.25	2.05
inches	0.185	0.015	0.155	0.064 0.045	0.022 0.017	0.014 0.010	1.256 1.240	0.265 0.255	0.100	0.300	0.138 0.120	0.32 0.30	0.395 0.300	0.01	0.081

Note

1. Plastic or metal protrusions of 0.01 inches maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT222-1		MS-001AF				95-03-11

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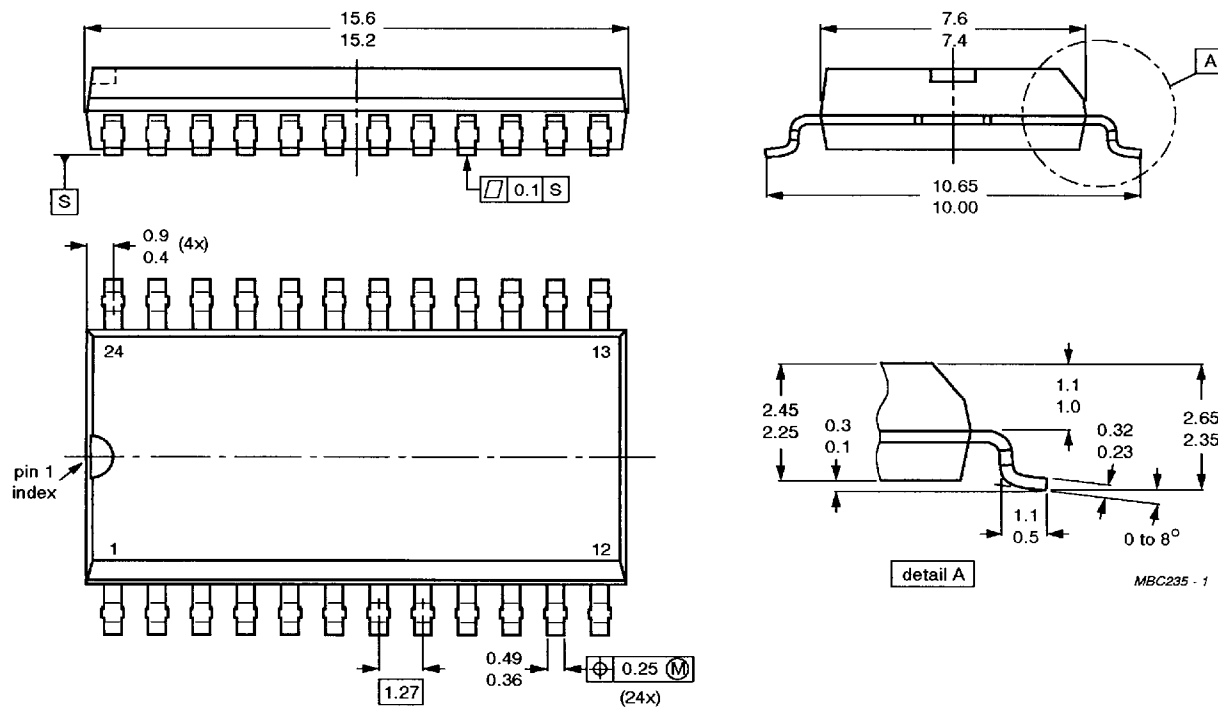
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Octal latched transceiver with dual enable (3-State)

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SO24: plastic small outline package; 24 leads; body width 7.5 mm

SOT137-1



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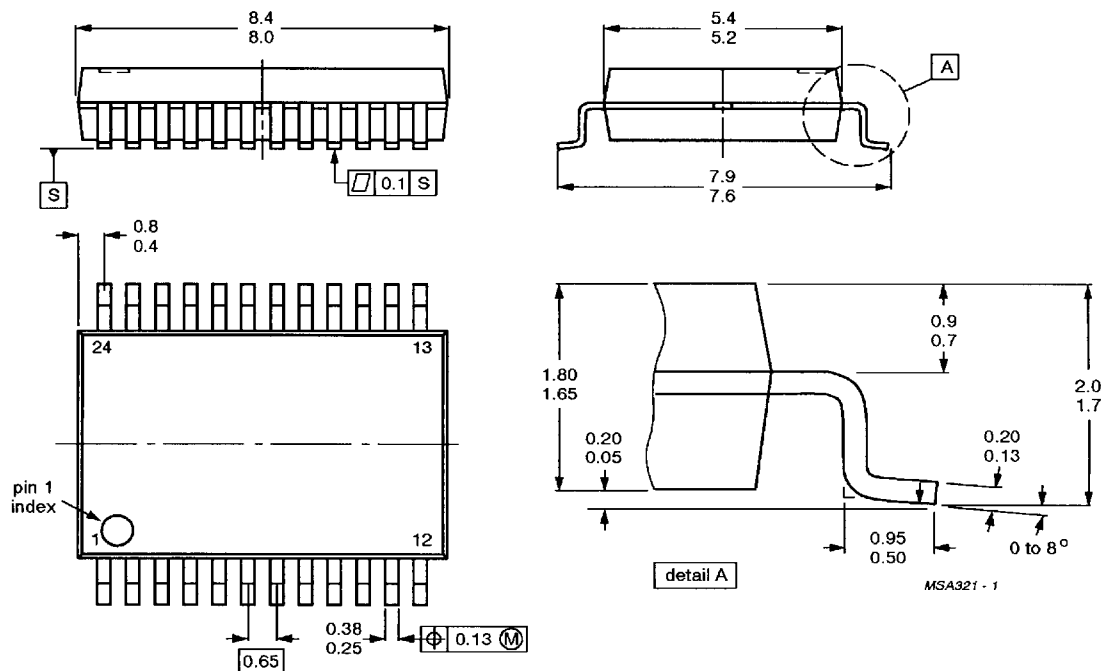
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Octal latched transceiver with dual enable (3-State)

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SSOP24: plastic shrink small outline package; 24 leads; body width 5.3mm

SOT340-1



Dimensions in mm.

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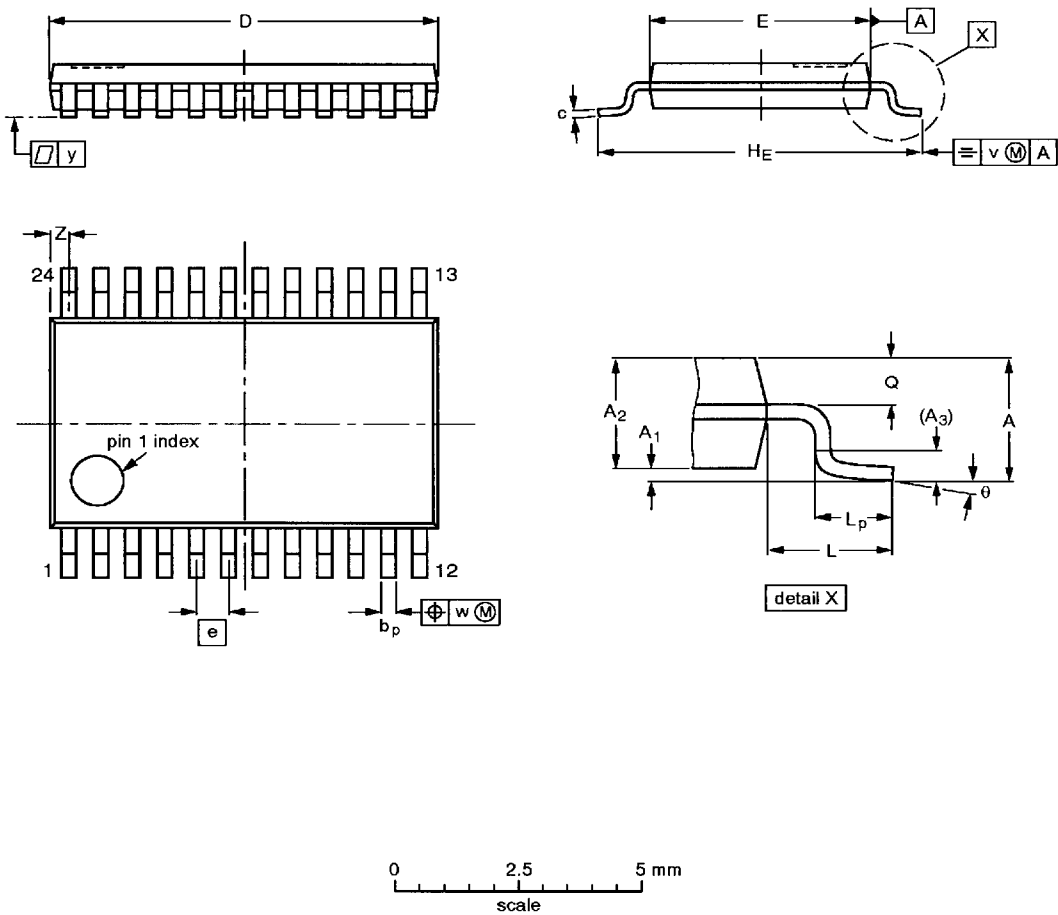
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Octal latched transceiver with dual enable
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TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm

SOT355-1



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽²⁾	e	H _E	L	L _p	Q	v	w	y	Z ⁽¹⁾	θ
mm	1.10	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	7.9 7.7	4.5 4.3	0.65	6.6 6.2	1.0	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT355-1		MO-153AD				93-06-16 95-02-04

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